

**TOSHIBA**

**TG2006F**

TOSHIBA GaAs LINEAR INTEGRATED CIRCUIT GaAs MONOLITHIC

**TG2006F**

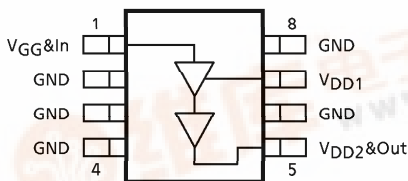
## 1.9GHz BAND POWER AMPLIFIER

### PHS, DIGITAL CORDLESS TELECOMMUNICATION

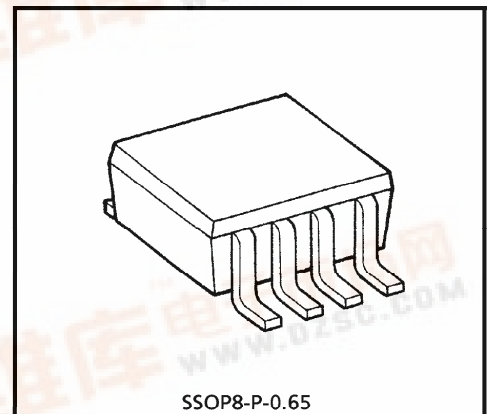
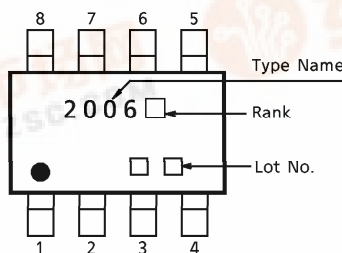
#### FEATURES

- Positive Voltage Operation :  $V_D = 3V$ ,  $V_G = 0$  to  $3V$
- Low Current Consumption :  $I_t = 130mA$  (Typ.)
- Small Package : SM8 Package  
(2.9\*2.8\*1.1mm)
- Low Cost : Can be achieved minimum function.

#### PIN ASSIGNMENT (TOP VIEW)



#### MARKING



Weight : 0.02g (Typ.)

#### MAXIMUM RATINGS ( $T_a = 25^\circ C$ )

CHARACTERISTIC	SYMBOL	RATING	UNIT
Supply Voltage	$V_{DD1}$	5	V
	$V_{DD2}$	5	V
Gate Voltage	$V_{GG}$	1	V
Input Power	$P_i$	10	mW
Power Dissipation	$P_d$ (Note)	250	mW
Operating Temperature Range	$T_{opr}$	-40~85	$^\circ C$
Storage Temperature Range	$T_{stg}$	-55~150	$^\circ C$

(Note) When mounted on  $2.5cm^2 \times 1.6t$  glass epoxy board.

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## CLASSIFY RANK

This device is classified by Fig.1.

And satisfy ELECTRICAL CHARACTERISTICS by  $V_g$  Condition on each rank.

Can't order to choose any rank.

RANK	$V_g$ CONDITION
A	$V_g = 0V$
B	$V_g = 1V$
C	$V_g = 3V$

Fig.1

## CAUTION

This device is electrostatic sensitivity. Please handle with caution.

## ELECTRICAL CHARACTERISTICS

( $V_d = 3V$ ,  $V_g =$  (Note 1),  $f = 1.9GHz$ ,  $T_a = 25^\circ C$ ,  $Z_g = Z_l = 50\Omega$  1/2 duty operation)

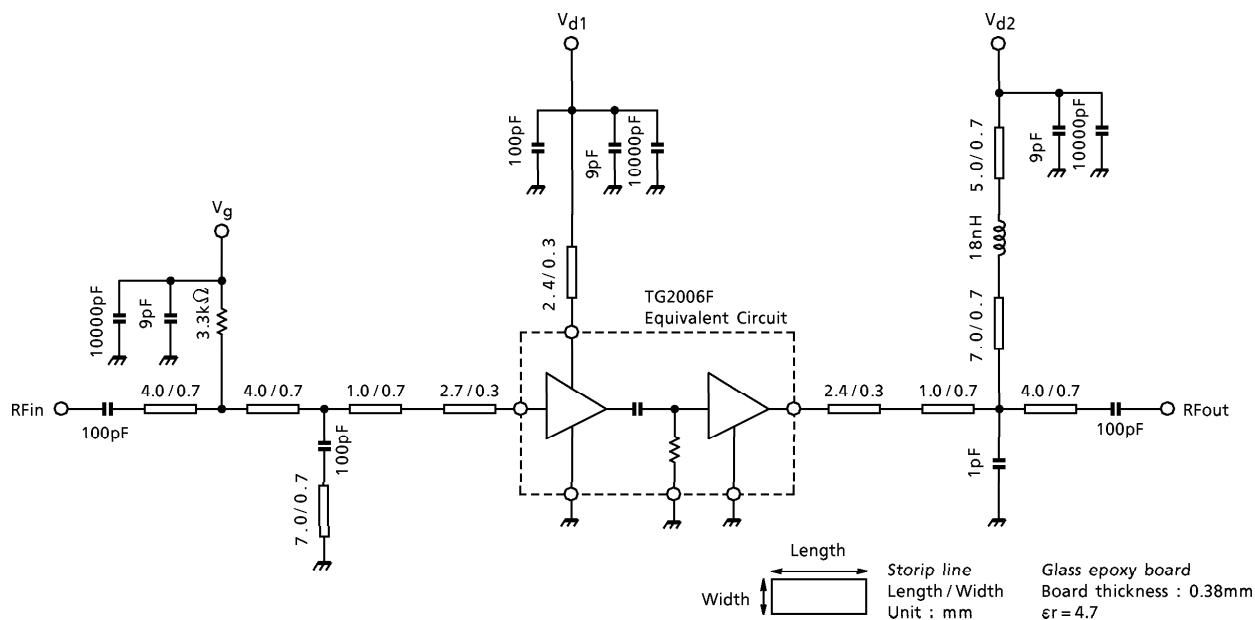
CHARACTERISTIC	SYMBOL	TEST CIRCUIT	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Frequency	$f_{range}$	—	—	1895	—	1918	MHz
Total Current	$I_t$	1	$P_O = 21dBmW$ , $P_i = \text{Regulation}$	—	130	150	mA
Gate Current	$I_G$	1		—	—	1	
Output Power	$P_O$	1	$P_i = 1dBmW$	21	—	—	dBmW
Small Signal Gain	$G_p$	1	$P_i = -20dBmW$	21	23	—	dB
Adjacent Channel Leakage Power Ratio	ACP (1)	1	$P_O = 21dBmW$ , $P_i = \text{Regulation}$ (Note 2)	—	$\Delta f = 600kHz$ —	$\Delta f = 600kHz$ - 55	dB
	ACP (2)	1			$\Delta f = 900kHz$ —	$\Delta f = 900kHz$ - 60	
Harmonics	$2f_0$	1	$P_O = 21dBmW$ , $P_i = \text{Regulation}$	—	—	- 30	dB
	$3f_0$	1		—	—	- 30	
Input VSWR	$VSWR_{in}$	1	$P_O = 21dBmW$ , $P_i = \text{Regulation}$	—	1.5	2.5	—
Load Mismatch	—	—	$V_d = 4.0V$ , $V_g =$ (Note 1), $P_O = 21dBmW$ , $P_i = \text{Regulation}$ , $Z_g = 50\Omega$ VSWR Load = 20 : 1 all phase	No Degradation			—
Stability	—	—	$V_d = 2.7 \sim 4.0V$ , $V_g =$ (Note 1), $P_i = -2mW \sim 4dBmW$ , $Z_g = 50\Omega$ VSWR Load = 6 : 1 all phase	All spurious output than 60dB below desired signal			—

(Note 1)  $V_g$  Voltage is decided on Fig.1.

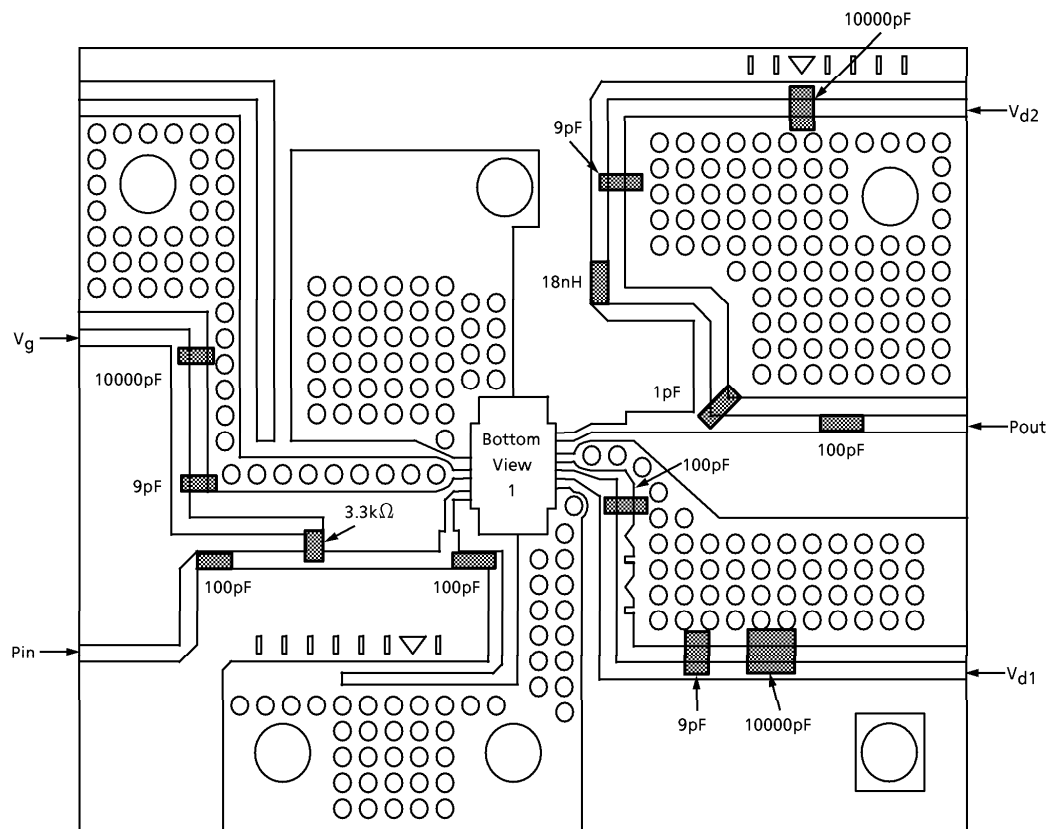
(Note 2) Input signal is modulated to  $\pi/4$ QPSK ( $\alpha = 0.5$ ). Bit rate is 384kbps.

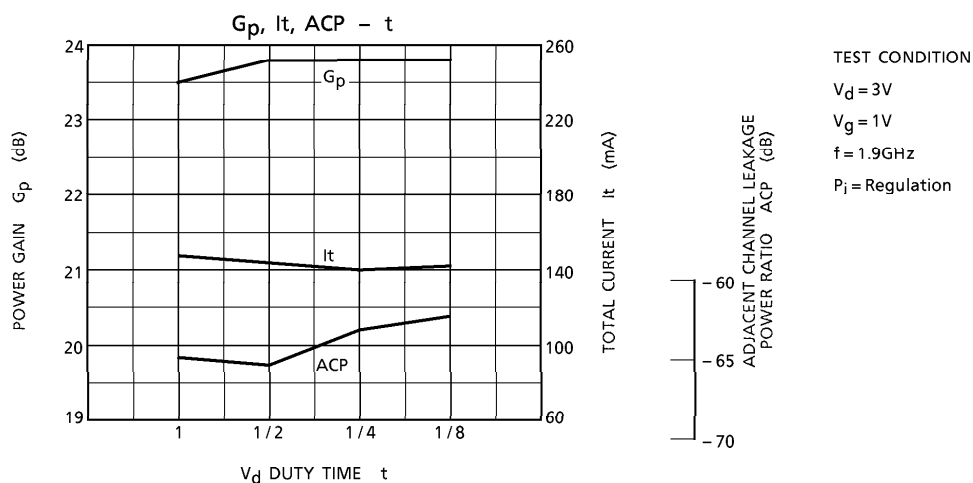
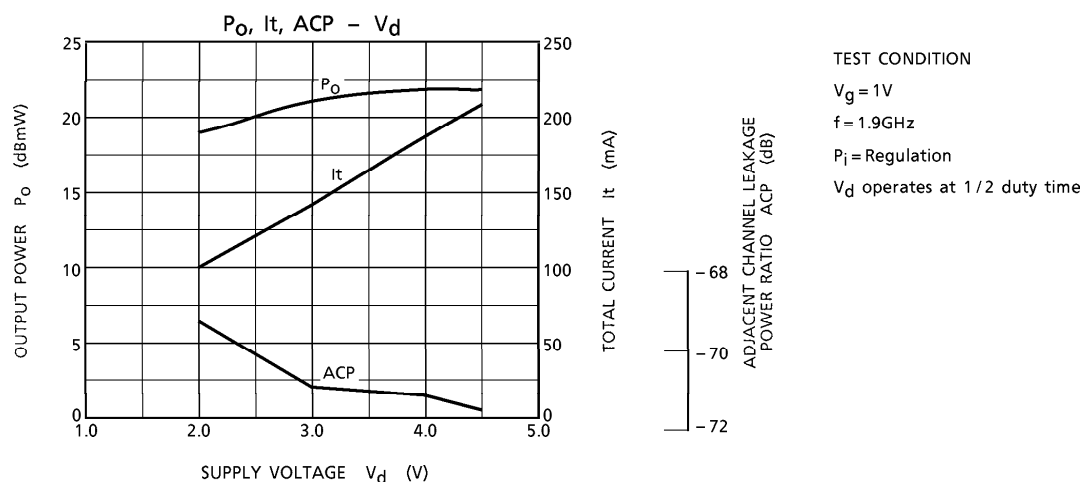
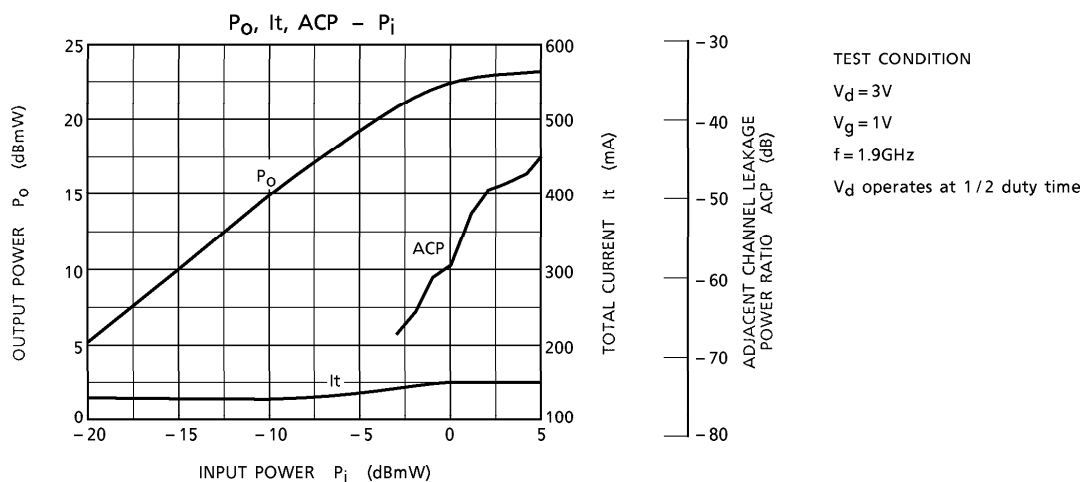
(Note 3)  $V_d = V_{d1} = V_{d2}$ ,  $I_t = I_{d1} + I_{d2}$

## TEST CIRCUIT 1 (RF TEST CIRCUIT)



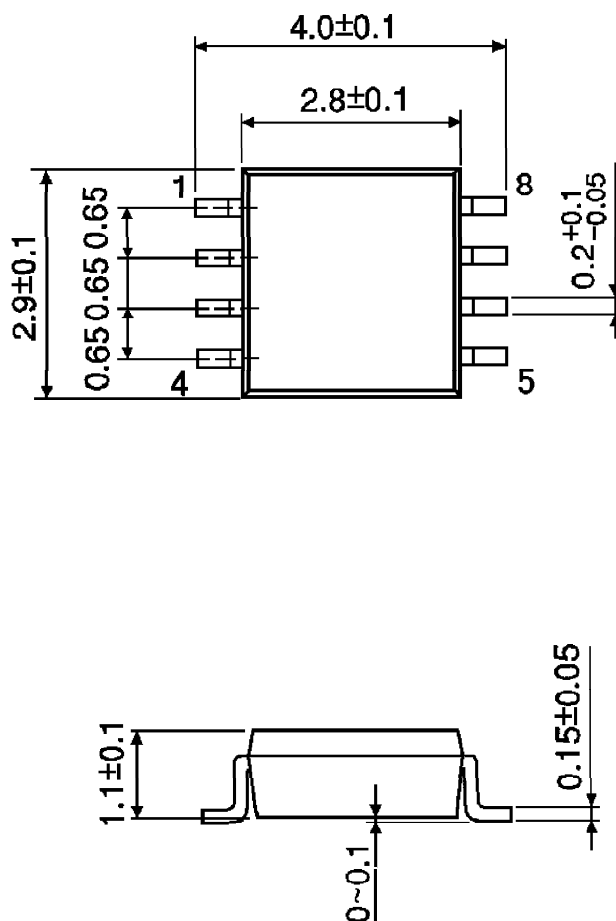
## RF TEST BOARD





OUTLINE DRAWING  
SSOP8-P-0.65

Unit : mm



Weight : 0.02g (Typ.)